

**Search Notes**

**Application/Control No.**

10/566,488

**Examiner**

Hien X. Vo

**Applicant(s)/Patent under Reexamination**

FENDT ET AL.

**Art Unit**

2863

**SEARCHED**

Class	Subclass	Date	Examiner
702	141	9/25/2006	VXH
	142		
	145		
701	45-46		
	70		
	91		
180	268		
	271		
	282		
280	734		
	735		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Plus search	9/21/2006	VXH
EAST	9/25/2006	VXH
Consulted with Tan Nguyen (primary AU 3661) ----> 701/45/46/70/91 180/268/271/282 280/734/735	9/25/2006	VXH
Interference search 702/141/142/145 701/45/46/70/91 180/268/271/282 280/734/735 See the print out	9/25/2006	VXH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	141 142 145	9/25/2006	VXH
701	45/46 70/9		
180	268/271 282		
	280/734/735		